

<b>Notice of References Cited</b>	Application/Control No. 10/004,192		Applicant(s)/Patent Under Reexamination TARQUINI, RICHARD P.	
	Examiner SARGON N. NANO		Art Unit 2457	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,374,260	04-2002	Hoffert et al.	707/104.1
*	B	US-2002/0087573	07-2002	Reuning et al.	707/102
*	C	US-2002/0054167	05-2002	Hugh, Harlan M.	345/854
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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**NON-PATENT DOCUMENTS**

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